


<b>Search Notes</b>  	<b>Application/Control No.</b>  09990887	<b>Applicant(s)/Patent Under Reexamination</b>  HAN ET AL.
	<b>Examiner</b>  Jason Mitchell	<b>Art Unit</b>  2193

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
inventor search	3/13/09	/jrm/
east search w/ ltd. class search 717/168-178	3/13/09	/jrm/
east search w/ ltd class search 717/168-178	9/8/09	/jrm/
consulted G. Hayse re: recapture	9/8/09	/jrm/
east search w/ ltd class search 717/168-178	8/2/10	/jrm/
consulted G. Hayse re: recapture	8/2/10	/jrm/
east search w/ ltd class search 717/168-178	2/23/11	/jrm/
east search w/ ltd class search 717/168-178	9/28/11	/jrm/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Jason Mitchell/  
Examiner,Art Unit 2193

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Primary Examiner,Art Unit 2193